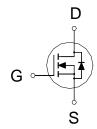




N-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

BVDSS	80V			
RDSON (MAX.)	9m Ω			
lo	103A			





UIS, Rg 100% Tested Pb-Free Lead Plating



ABSOLUTE MAXIMUM RATINGS (T_c = 25 °C Unless Otherwise Noted)

PARAMETERS/TES	ST CONDITIO	SYMBOL	LIMITS	UNIT		
Gate-Source Voltage		V_{GS}	±25	V		
Continuous Drain Current	T _C = 25 °C	I _D	103			
Continuous Brain Carrent	T _C = 100 °C	U.	80	А		
Pulsed Drain Current ¹		I _{DM}	200			
Avalanche Current		I _{AS}	45			
Avalanche Energy	L = 0.3ml	H, ID=45A, RG=25Ω	E _{AS}	303	mJ	
Repetitive Avalanche Energy ²	L = 0.1m	ıH	E _{AR}	101	1113	
Power Dissipation	T _C = 25 °	c	P _D	223	W	
	T _C = 100	°C	. 0	89	•••	
Operating Junction & Storage Temp	erature Range		T _j , T _{stg}	-55 to 150	°C	

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNIT
Junction-to-Case	$R_{ heta JC}$		0.56	°C/W
Junction-to-Ambient	$R_{ hetaJA}$		60	C / W

¹Pulse width limited by maximum junction temperature.

²Duty cycle $\leq 1\%$





ELECTRICAL CHARACTERISTICS (T_c = 25 °C, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS		UNIT		
			MIN	TYP MAX		
	_	STATIC				
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V$, $I_D = 250 \mu A$	80			٧
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	2.0	3.0	4.0	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0V, V_{GS} = \pm 25V$			±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 60V$, $V_{GS} = 0V$			1	μΑ
		$V_{DS} = 50V$, $V_{GS} = 0V$, $T_{J} = 125$ °C			25	
On-State Drain Current ¹	I _{D(ON)}	V _{DS} = 10V, V _{GS} = 10V	103			Α
Drain-Source On-State Resistance ¹	R _{DS(ON)}	$V_{GS} = 10V, I_D = 30A$		7.5	9	mΩ
Forward Transconductance ¹	g fs	$V_{DS} = 5V$, $I_{D} = 30A$		40		S
		DYNAMIC				
Input Capacitance	C _{iss}			3905		
Output Capacitance	C _{oss}	$V_{GS} = 0V$, $V_{DS} = 25V$, $f = 1MHz$		378		pF
Reverse Transfer Capacitance	C _{rss}			363		
Gate Resistance	R_{g}	V _{GS} = 15mV, V _{DS} = 0V, f = 1MHz		2.5		Ω
Total Gate Charge ^{1,2}	Q_{g}	$V_{DS} = 40V$, $V_{GS} = 10V$,		64		
Gate-Source Charge ^{1,2}	Q_{gs}	$I_D = 30A$		19		nC
Gate-Drain Charge ^{1,2}	Q_{gd}			22		
Turn-On Delay Time ^{1,2}	t _{d(on)}			30		
Rise Time ^{1,2}	t _r	$V_{DS} = 40V$,		200		nS
Turn-Off Delay Time ^{1,2}	t _{d(off)}	I_D = 1A, V_{GS} = 10V, R_{GS} = 6 Ω		100		
Fall Time ^{1,2}	t _f			150		1
SOURCE-D	RAIN DIODE RA	TINGS AND CHARACTERISTICS (T _c = 25	°C)			
Continuous Current	I _S				103	- A
Pulsed Current ³	I _{SM}				200] ^
Forward Voltage ¹	V_{SD}	$I_F = I_S$, $V_{GS} = 0V$			1.3	V
Reverse Recovery Time	t _{rr}	$I_F = 30A$, $dI_F/dt = 100A / \mu S$		130		nS
Reverse Recovery Charge	Q _{rr}			400		nC
	_					

 $^{^{1}}$ Pulse test : Pulse Width \leq 300 µsec, Duty Cycle \leq 2%.

 $^{^{\}rm 2}Independent$ of operating temperature.

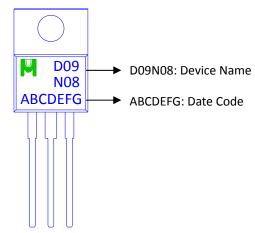
³Pulse width limited by maximum junction temperature.





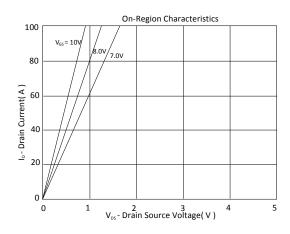
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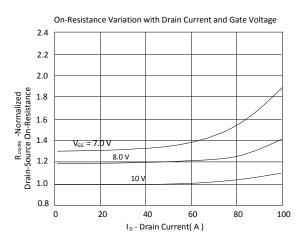
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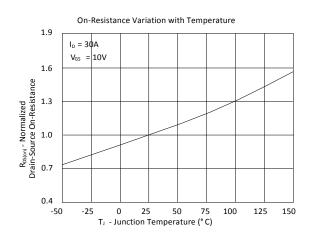


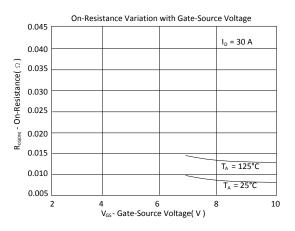
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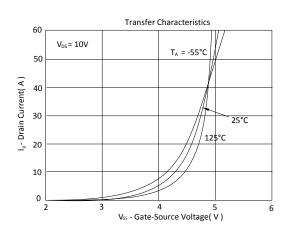
TYPICAL CHARACTERISTICS

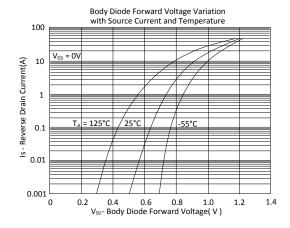






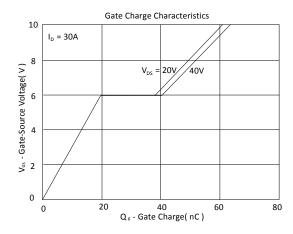


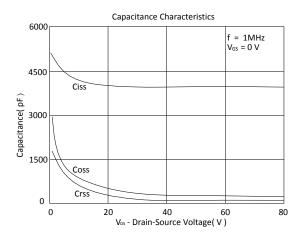


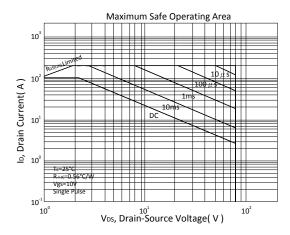


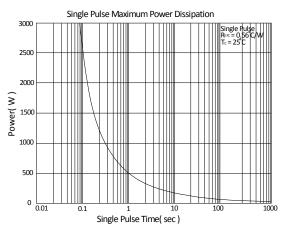
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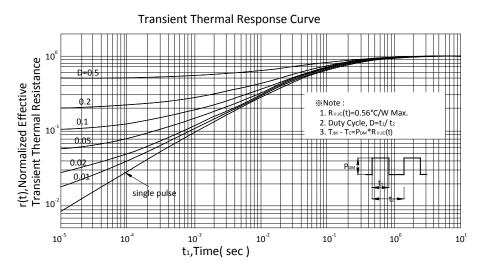
杰力科技股份有限公司 Excelliance MOS Corporation







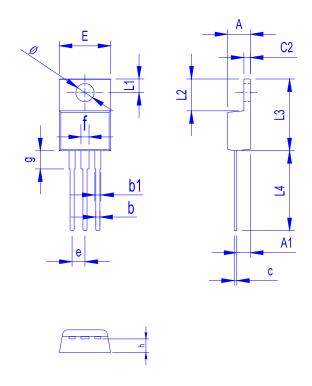




EMD09N08E



Outline Drawing



Dimension in mm

Dimension	А	b	b1	С	c2	E	L1	L2	L3	L4	ø	е	f	g	h
Min.	4.20	0.70	0.90	0.30	1.10	9.80	2.55	6.10	14.80	13.50	3.40	2.35	1.30	3.40	2.40
Max.	4.80	1.10	1.50	0.70	1.50	10.50	2.85	6.50	15.40	14.50	3.80	2.75	1.90	3.80	3.00